

IRF8707GPbF

HEXFET® Power MOSFET

Applications

- Control MOSFET of Sync-Buck Converters used for Notebook Processor Power
- Control MOSFET for Isolated DC-DC Converters in Networking Systems

| | | |
|-----------------------|------------------------------------|----------------------|
| V_{DS} | R_{DS(on)} max | Q_g |
| 30V | 11.9mΩ@V_{GS} = 10V | 6.2nC |

Benefits

- Very Low Gate Charge
- Very Low R_{DS(on)} at 4.5V V_{GS}
- Ultra-Low Gate Impedance
- Fully Characterized Avalanche Voltage and Current
- 20V V_{GS} Max. Gate Rating
- 100% tested for R_g
- Lead-Free
- Halogen-Free



Description

The IRF8707GPbF incorporates the latest HEXFET Power MOSFET Silicon Technology into the industry standard SO-8 package. The IRF8707GPbF has been optimized for parameters that are critical in synchronous buck operation including R_{ds(on)} and gate charge to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors for notebook and Netcom applications.

Absolute Maximum Ratings

| | Parameter | Max. | Units |
|--|---|--------------|-------|
| V _{DS} | Drain-to-Source Voltage | 30 | V |
| V _{GS} | Gate-to-Source Voltage | ± 20 | |
| I _D @ T _A = 25°C | Continuous Drain Current, V _{GS} @ 10V | 11 | A |
| I _D @ T _A = 70°C | Continuous Drain Current, V _{GS} @ 10V | 9.1 | |
| I _{DM} | Pulsed Drain Current ① | 88 | |
| P _D @ T _A = 25°C | Power Dissipation | 2.5 | W |
| P _D @ T _A = 70°C | Power Dissipation | 1.6 | |
| | Linear Derating Factor | 0.02 | W/°C |
| T _J | Operating Junction and | -55 to + 150 | °C |
| T _{STG} | Storage Temperature Range | | |

Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|------------------|--------------------------|------|------|-------|
| R _{θJL} | Junction-to-Drain Lead ⑤ | — | 20 | °C/W |
| R _{θJA} | Junction-to-Ambient ④ | — | 50 | |

Notes ① through ⑤ are on page 9

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IR Rectifier

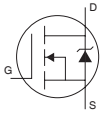
Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|------------------------------|--------------------------------------|------|-------|------|---------------------|---|
| BV_{DSS} | Drain-to-Source Breakdown Voltage | 30 | — | — | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| $\Delta BV_{DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 0.022 | — | $V/^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$ |
| $R_{DS(on)}$ | Static Drain-to-Source On-Resistance | — | 9.3 | 11.9 | $m\Omega$ | $V_{GS} = 10V, I_D = 11A$ ③ |
| | | — | 14.2 | 17.5 | | $V_{GS} = 4.5V, I_D = 8.8A$ ③ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 1.35 | 1.80 | 2.35 | V | $V_{DS} = V_{GS}, I_D = 25\mu A$ |
| $\Delta V_{GS(th)}$ | Gate Threshold Voltage Coefficient | — | -5.8 | — | $mV/^\circ\text{C}$ | $V_{DS} = V_{GS}, I_D = 25\mu A$ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 1.0 | μA | $V_{DS} = 24V, V_{GS} = 0V$ |
| | | — | — | 150 | | $V_{DS} = 24V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | $V_{GS} = 20V$ |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | $V_{GS} = -20V$ |
| g_{fs} | Forward Transconductance | 25 | — | — | S | $V_{DS} = 15V, I_D = 8.8A$ |
| Q_g | Total Gate Charge | — | 6.2 | 9.3 | nC | $V_{DS} = 15V$ $V_{GS} = 4.5V$ $I_D = 8.8A$ See Figs. 15 & 16 |
| Q_{gs1} | Pre-Vth Gate-to-Source Charge | — | 1.4 | — | | |
| Q_{gs2} | Post-Vth Gate-to-Source Charge | — | 0.7 | — | | |
| Q_{gd} | Gate-to-Drain Charge | — | 2.2 | — | | |
| Q_{godr} | Gate Charge Overdrive | — | 1.9 | — | | |
| Q_{sw} | Switch Charge ($Q_{gs2} + Q_{gd}$) | — | 2.9 | — | | |
| Q_{oss} | Output Charge | — | 3.7 | — | nC | $V_{DS} = 16V, V_{GS} = 0V$ |
| R_g | Gate Resistance | — | 2.2 | 3.7 | Ω | |
| $t_{d(on)}$ | Turn-On Delay Time | — | 6.7 | — | ns | $V_{DD} = 15V, V_{GS} = 4.5V$ $I_D = 8.8A$ $R_G = 1.8\Omega$ See Fig. 18 |
| t_r | Rise Time | — | 7.9 | — | | |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 7.3 | — | | |
| t_f | Fall Time | — | 4.4 | — | | |
| C_{iss} | Input Capacitance | — | 760 | — | pF | $V_{GS} = 0V$ $V_{DS} = 15V$ $f = 1.0\text{MHz}$ |
| C_{oss} | Output Capacitance | — | 170 | — | | |
| C_{rss} | Reverse Transfer Capacitance | — | 82 | — | | |

Avalanche Characteristics

| | Parameter | Typ. | Max. | Units |
|----------|---------------------------------|------|------|-------|
| E_{AS} | Single Pulse Avalanche Energy ② | — | 53 | mJ |
| I_{AR} | Avalanche Current ① | — | 8.8 | A |

Diode Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------|---|--|------|------|-------|--|
| I_S | Continuous Source Current (Body Diode) | — | — | 3.1 | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I_{SM} | Pulsed Source Current (Body Diode) ① | — | — | 88 | A | |
| V_{SD} | Diode Forward Voltage | — | — | 1.0 | V | $T_J = 25^\circ\text{C}, I_S = 8.8A, V_{GS} = 0V$ ③ |
| t_{rr} | Reverse Recovery Time | — | 12 | 18 | ns | $T_J = 25^\circ\text{C}, I_F = 8.8A, V_{DD} = 15V$ |
| Q_{rr} | Reverse Recovery Charge | — | 13 | 20 | nC | $di/dt = 300A/\mu s$ ③ |
| t_{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

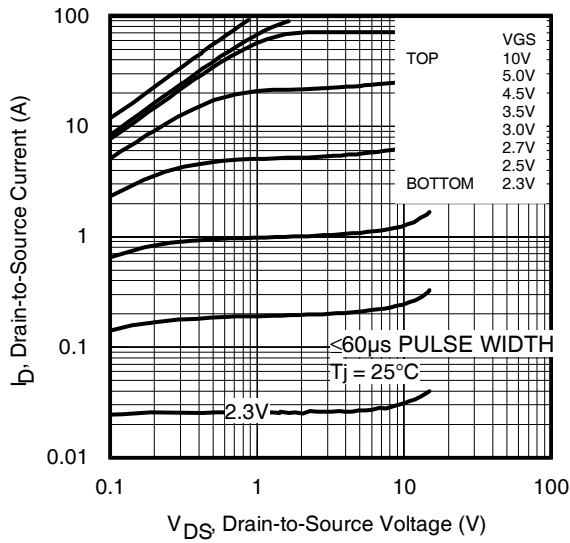


Fig 1. Typical Output Characteristics

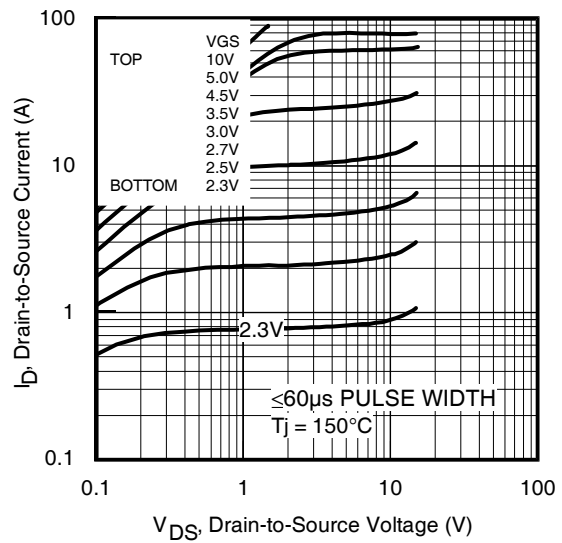


Fig 2. Typical Output Characteristics

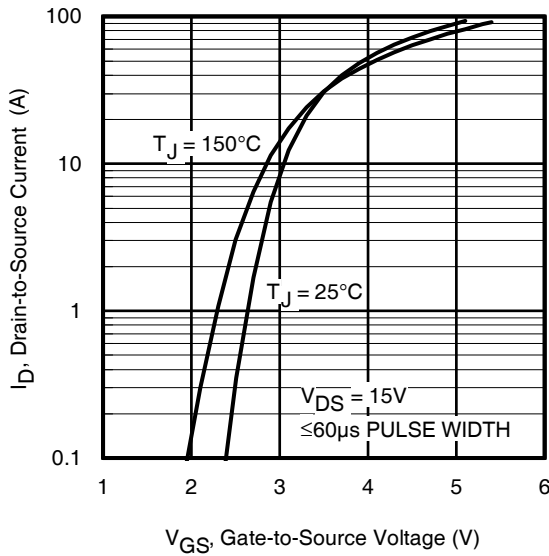


Fig 3. Typical Transfer Characteristics

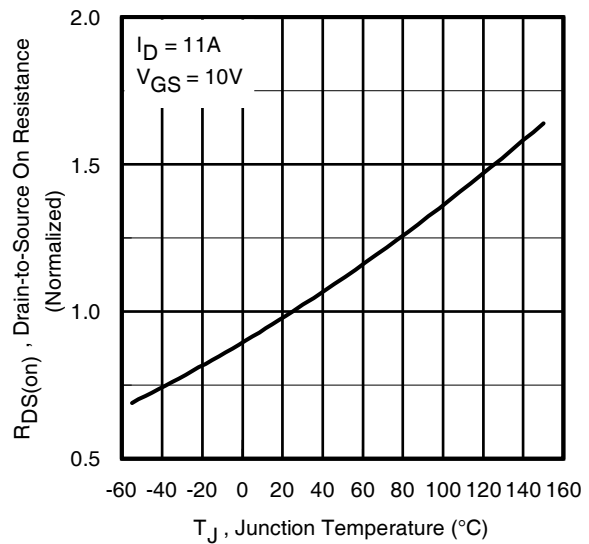


Fig 4. Normalized On-Resistance vs. Temperature

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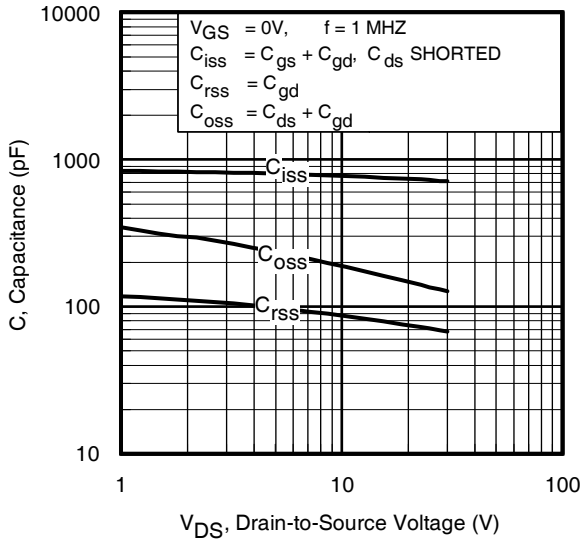


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

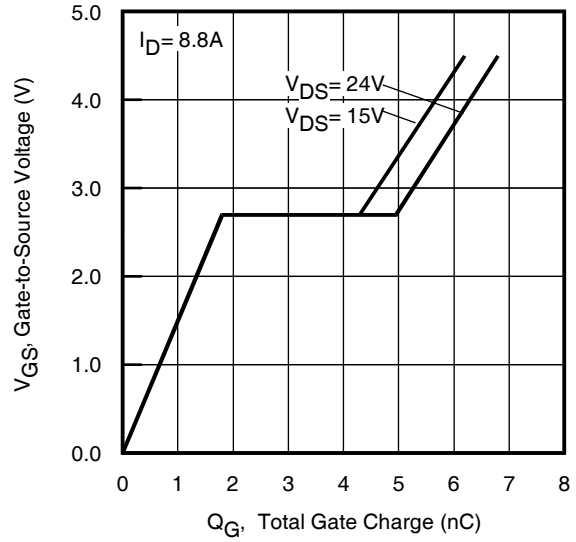


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

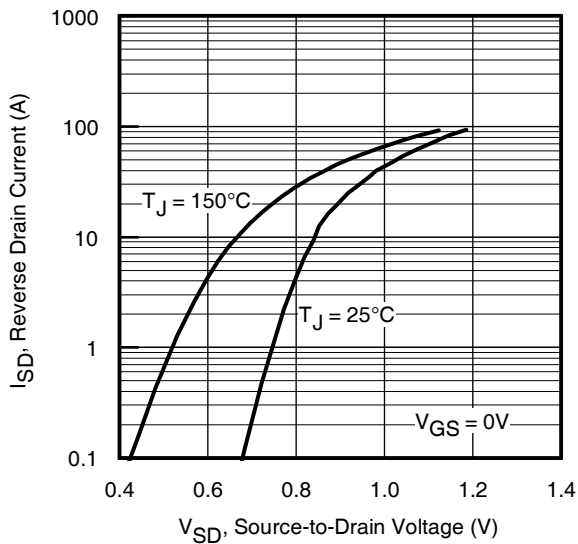


Fig 7. Typical Source-Drain Diode Forward Voltage

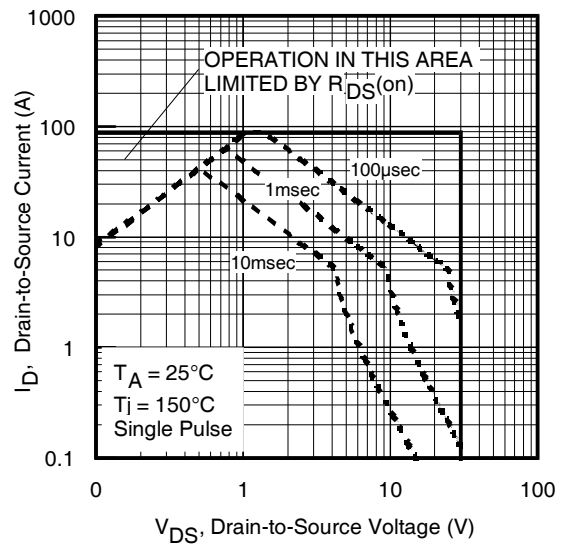


Fig 8. Maximum Safe Operating Area

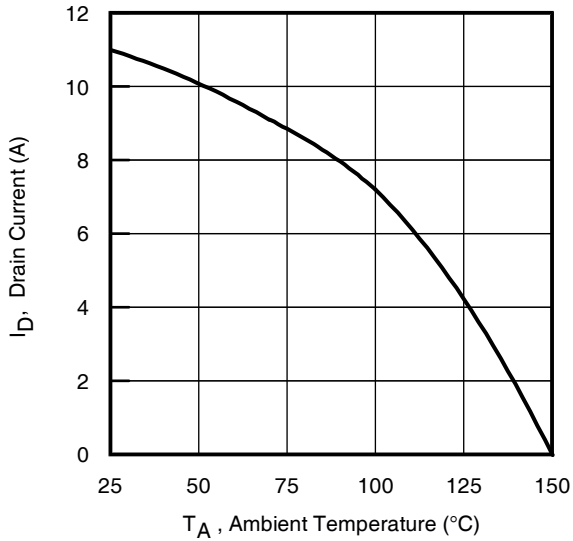


Fig 9. Maximum Drain Current vs. Ambient Temperature

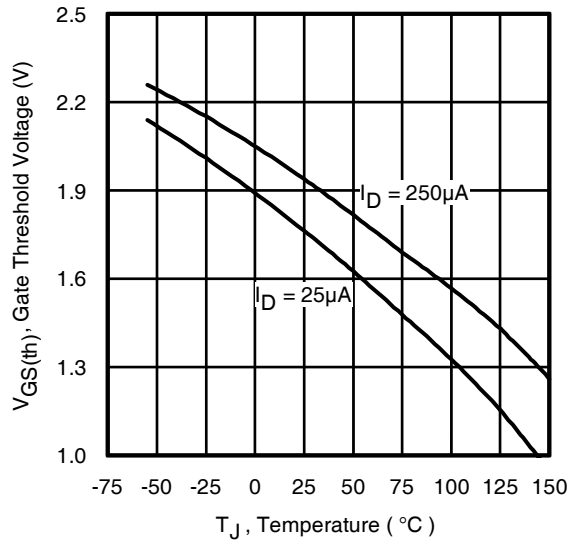


Fig 10. Threshold Voltage vs. Temperature

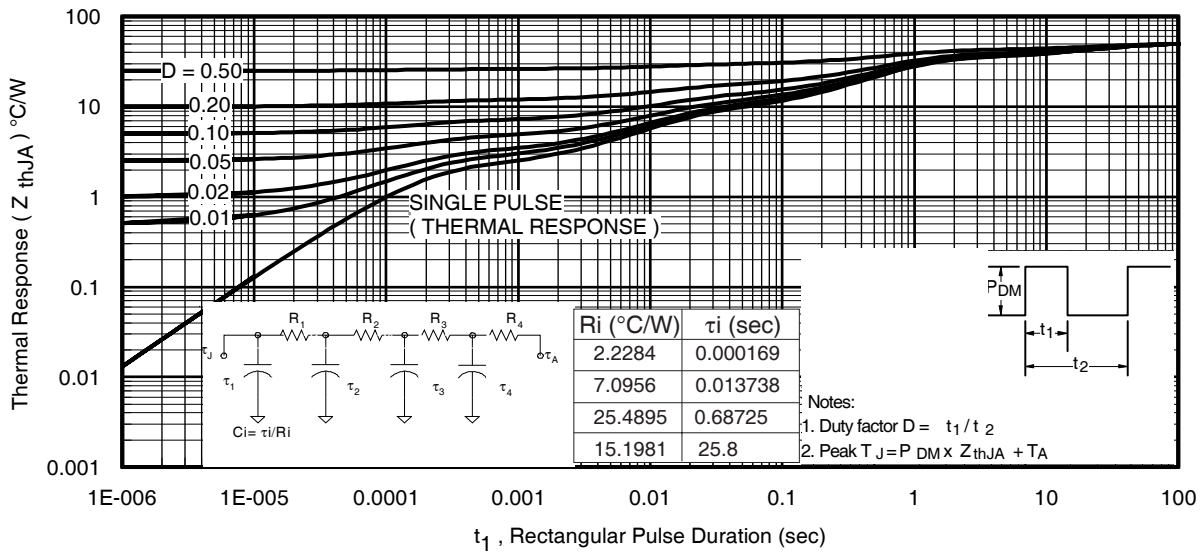


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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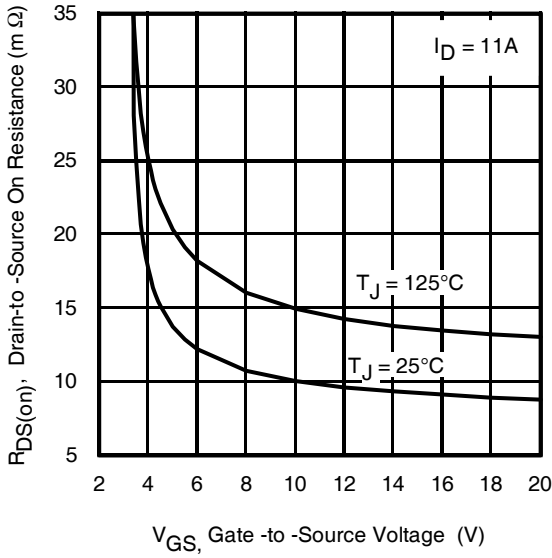


Fig 12. On-Resistance vs. Gate Voltage

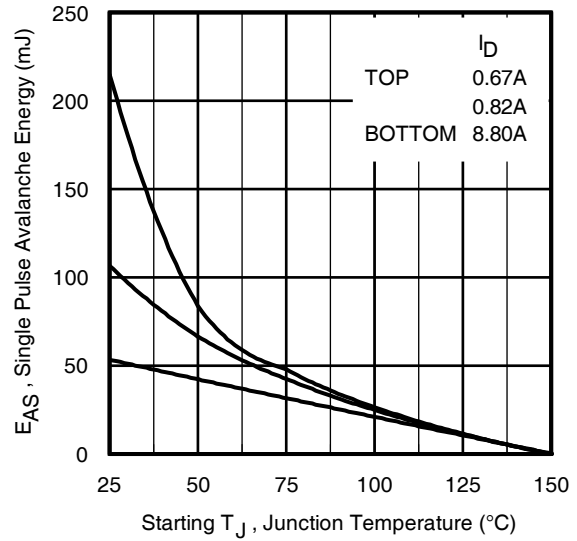


Fig 13. Maximum Avalanche Energy vs. Drain Current

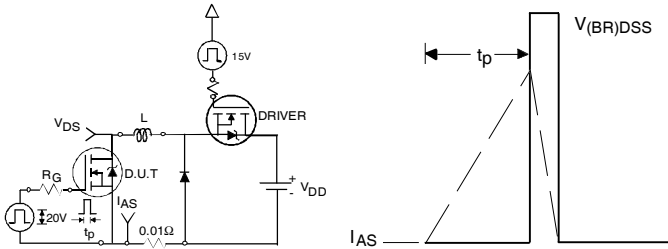


Fig 14. Unclamped Inductive Test Circuit and Waveform

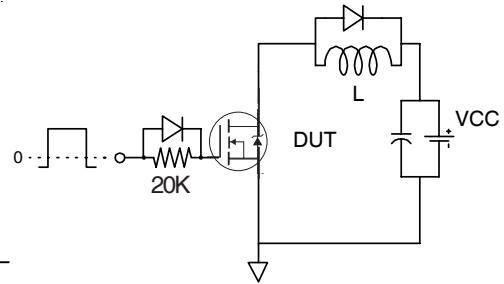
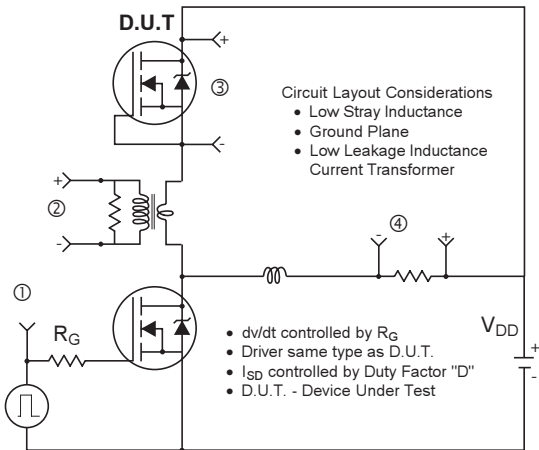


Fig 15. Gate Charge Test Circuit



Fig 16. Gate Charge Waveform



* $V_{GS} = 5V$ for Logic Level Devices

Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETS

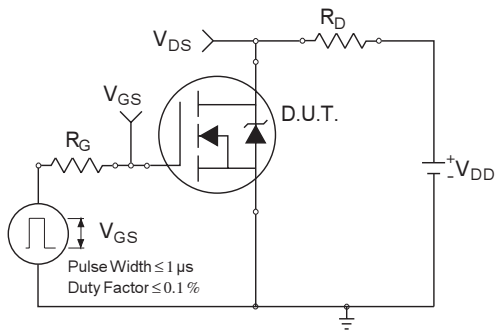


Fig 18a. Switching Time Test Circuit

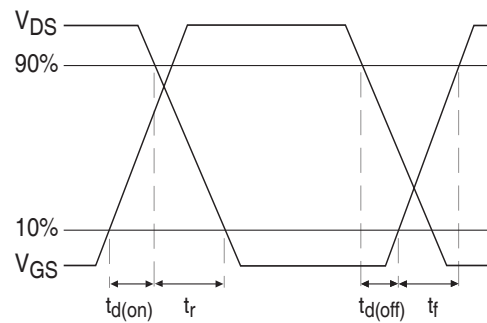
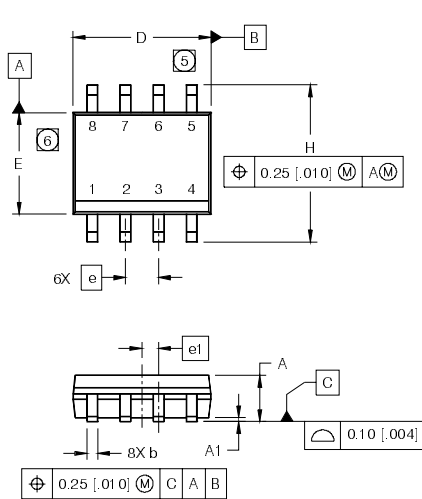


Fig 18b. Switching Time Waveforms

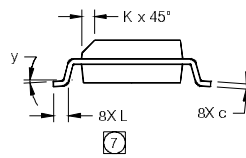
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SO-8 Package Outline (MOSFET & Fetky)

Dimensions are shown in millimeters (inches)



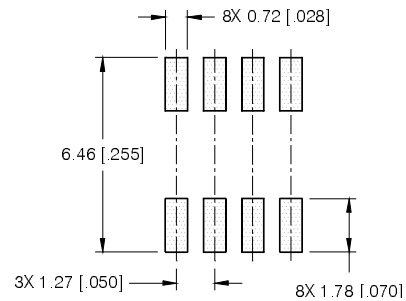
| DIM | INCHES | | MILLIMETERS | |
|-----|------------|-------|-------------|------|
| | MIN | MAX | MIN | MAX |
| A | .0532 | .0688 | 1.35 | 1.75 |
| A1 | .0040 | .0098 | 0.10 | 0.25 |
| b | .013 | .020 | 0.33 | 0.51 |
| c | .0075 | .0098 | 0.19 | 0.25 |
| D | .189 | .1968 | 4.80 | 5.00 |
| E | .1497 | .1574 | 3.80 | 4.00 |
| e | .050 BASIC | | 1.27 BASIC | |
| e1 | .025 BASIC | | 0.635 BASIC | |
| H | .2284 | .2440 | 5.80 | 6.20 |
| K | .0099 | .0196 | 0.25 | 0.50 |
| L | .016 | .050 | 0.40 | 1.27 |
| y | 0° | 8° | 0° | 8° |



NOTES:

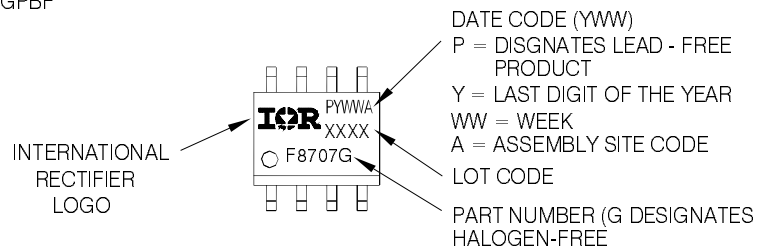
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [0.006].
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [0.010].
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

FOOTPRINT



SO-8 Part Marking Information

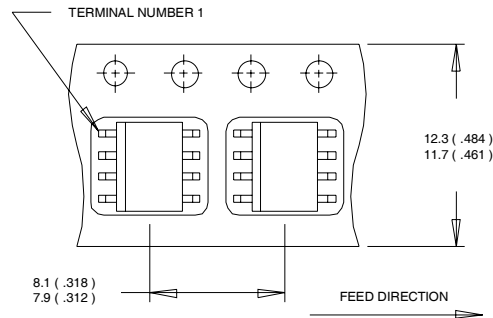
EXAMPLE: THIS IS AN IRF8707GPBF



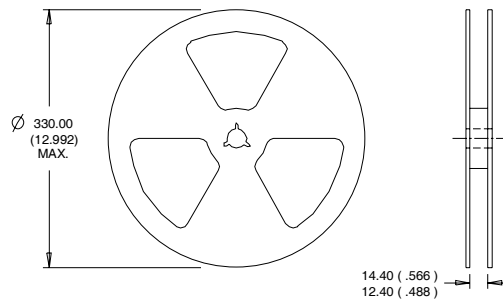
Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

SO-8 Tape and Reel

Dimensions are shown in millimeters (inches)



- NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 1.38\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 8.8\text{A}$.
- ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ When mounted on 1 inch square copper board.
- ⑤ R_{θ} is measured at T_J of approximately 90°C .

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package>

Data and specifications subject to change without notice.

This product has been designed and qualified for the Consumer market.

Qualification Standards can be found on IR's Web site.

Mouser Electronics

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